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Patentanmeldung Nr. | Patent application No. | Demande de brevet n°

03425218.9

Der Präsident des Europäischen Patentamts;
Im Auftrag

For the President of the European Patent Office

Le Président de l'Office européen des brevets
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Bezeichnung der Erfindung/Title of the invention/Titre de l'invention:
(Falls die Bezeichnung der Erfindung nicht angegeben ist, siehe Beschreibung.
If no title is shown please refer to the description.
Si aucun titre n'est indiqué se referer à la description.)

Method of generating a switching sequence for an unary array of conducting branches and a relative thermometrically decoded digital-to-analog conveter

In Anspruch genommene Priorität(en) / Priority(ies) claimed /Priorité(s) revendiquée(s)
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FIELD OF THE INVENTION

The present invention relates to digital-analog converters and in particular to a method of generating a switching sequence for an unary array of conducting branches and a relative thermometrically decoded digital-to-analog converter having a desired integral non-linearity (briefly INL) error function.

BACKGROUND OF THE INVENTION

Digital-analog (D/A) converters are widely used in many applications, such as wireless communications, signal reconstruction, waveforms generation etc.. Basically, a D/A converter may be realized with an array of conducting branches that generate binary weighted constant currents (binary array) and/or identical currents (unary array). These conducting branches may include capacitors or current generators, selectable by respective switches for delivering current toward a summing line or toward ground.

For sake of simplicity, let us refer to a D/A converter, the conducting branches of which are realized with current generators, though what will be said will hold, *mutatis mutandis*, also for conducting branches realized with switched capacitors.

The conducting branches of a binary array are selected by respective bits of an input bit string, while the conducting branches of an unary array are selected according to a fixed switching sequence for making the unary array generate a total current corresponding to the input digital value.

For better comprehending the field of utility of this invention, let us refer to the so-called segmented converters, which generally have a binary weighted array of conducting branches, selected by the least significant bits of an input digital string, and an unary array that delivers a current corresponding to the digital value represented by the most significant bits, that is according to a so-called thermometer or thermometric decoding.

A sample unary array is depicted in Figure 1. As may be noticed, the current generators are selected according to a certain switching sequence and the output

current *Iout* corresponds to the sum of the currents circulating in the selected branches. Optionally, there may be a "dummy" area in the unary array, which may be used for realizing biasing circuits. In segmented digital-to-analog converters, the "dummy" area may be used for realizing a binary array.

When the digital input value to be converted by the unary array represents a certain number n, the current generators of the unary array from 1 to n are switched on, thus generating an output current *Iout* proportional to the digital input number n.

Ideally, a D/A converter should generate an output signal that varies linearly with the input bit string, which would happen if all the conducting branches were identical. Unfortunately, mismatches between conducting branches due to inaccuracies of the fabrication process (process spread), make the current delivered by each branch not exactly equal to the design value, but affected by an error that may depend on the position of the conducting branch on the silicon substrate.

In general, unary arrays are affected by a differential non-linearity (DNL) error and by an integral non-linearity (INL) error.

Indicating with $\bar{I}$ the average current delivered by the branches of an unary array and with I_j the current delivered by the j-th branch of the array in the switching sequence,

$$I_j = \bar{I} \cdot (1 + \varepsilon_j)$$

wherein ε_j is the relative deviation of the current I_j from the average current $\bar{I}$.

In an unary array not having a dummy area, the DNL error of the k-th branch in the switching sequence is

$$DNL(k) = \varepsilon_k$$

which represents a non-uniform deviation in the ideal current step amplitude between adjacent bit strings.

The INL error function is defined as

$$INL(k) = \sum_{j=1}^{k} \varepsilon_j$$

and gives the deviation of the real analog output signal from its ideal value as a percentage of the average current $\bar{I}$ for any value "k" of the switching sequence.

The absolute INL error of a switching sequence is the maximum absolute value of the relative INL error function.

An introduction on the INL and DNL errors of an unary array of a D/A thermometrically decoded converter is carried out in the article by Y. Cong and R. L. Geiger "Switching Sequence Optimization for Gradient Error Compensation in Thermometer-Decoded DAC Arrays", *IEEE Trans. on circuits and systems - II: analog and digital signal processing*, Vol. 47, No. 7, pages 585-595, July 2000.

The DNL error of a branch can be reduced only by reducing the process spread and is independent from the switching sequence. By contrast, the INL error function strongly depends on the switching sequence, as it may be easily inferred from the following example.

Two possible switching sequences of a mono-dimensional unary array having eight conducting branches are shown in Table 1. The conducting branch are affected by the indicated DNL errors (ε). The absolute values of the underlined numbers are the absolute INL errors of the switching sequences.

As may be noticed, the INL error function of the sequential switching sequence shows a maximum deviation of the analog output from its ideal value in the middle of the sequence. This situation is inconvenient, because the digital values input to a D/A converter are more likely in the middle of the range of conversion, rather than at the two ends thereof. Therefore, it is more convenient to switch the

mono-dimensional array of conducting branches of Table 1 according to a symmetrical sequence than according to a sequential sequence. Moreover, the absolute INL error for the symmetrical sequence is 7, while for the sequential sequence is 16.

In this very simple case, it is possible to determine by successive trials the switching sequence with the smallest absolute INL error, but for two-dimensional unary arrays of about a thousand of conducting branches the number of combinations is too large for determining a switching sequence with the desired INL error function by trials.

Many different methods of determining a switching sequence of a two-dimensional unary array of conducting branches and a relative D/A converter have been proposed.

The patent US 6,118,398 by G.J. Fisher et al. discloses a digital-analog converter having an unary array of current sources that are selected according to a sequence that ensures a relatively small absolute integral non-linearity error. The suggested switching sequence is substantially a mixed symmetrical sequence, in which the current sources that are in the middle of the array have median positions in the switching sequence, while current sources that are in borderline regions of the array are at the beginning or at the end of the sequence.

The patent US 5,057,838 by K. Tsuji et al. discloses a D/A converter having a plurality of conducting branches of a two-dimensional array, wherein the switching sequence is determined in order to make the center of the current contributions delivered by the conducting branches of the array coincide with the center of the array.

The document "A 14-bit Intrinsic Accuracy Q2 Random Walk CMOS DAC" by Van der Plas, Steyaert et al., JSCC 12 Dec '99, discloses a method of determining the switching sequence of the switches of a D/A converter organized in matrix form, exploiting the so-called "Q^2 random walk" algorithm.

The document "Switching Sequence Optimization for Gradient Error Compensation in Thermometer-Decoded DAC Arrays", by Cong, Geiger, JSSC 7 Jul '00, discloses an algorithm to find the so-called "INL bounded" switching sequence for an unary array of branches organized in matrix form.

Unfortunately, the absolute INL errors of the D/A converters realized with the above techniques remain relatively large.

OBJECT AND SUMMARY OF THE INVENTION

As it will be more clearly described hereinafter, the array of conducting branches is affected by an error whose spatial distribution has an anti-symmetrical linear component, a quadratic symmetrical component, components of higher orders and a random component. The known thermometrically decoded converters are affected by quite large INL errors because the switching sequence of their unary array of conducting branches is not determined in a way that would optimally compensate the quadratic component of the error distribution.

The objective of the method of this invention is to determine switching sequences of two-dimensional unary arrays of conducting branches of thermometrically decoded D/A converters, in a way that will ensure that the relative INL error function be contained between pre-established symmetrical upper and lower bound functions. These functions may be constant, such to ensure an absolute INL error smaller than a pre-established value, or approaching zero in correspondence of mid way values of the switching sequence from a certain maximum value in correspondence of the two ends of the range of conversion. This last solution is preferable when the D/A converter is likely to work almost constantly about the middle of its range of conversion.

When these upper and lower bound functions are constant, the obtained switching sequence compensates both the linear and the quadratic component of the error distribution and therefore is affected by a very small absolute INL error, which depends essentially on the random component of the error distribution.

The method of this invention may be easily implemented by a computer program and allows the realization of thermometrically decoded D/A converters affected by a known limited INL error function.

The invention is more precisely defined in the annexed claims.

BRIEF DESCRIPTION OF THE DRAWINGS

The advantages of this invention will become more evident through a detailed description referring to the attached drawings, wherein:

Figure 1 illustrates a sample 16x16 unary array;

Table 1 compares the INL error functions of two switching sequences for a mono-dimensional array;

Figure 2 shows a sample joint error distribution;

Figure 3 shows how to build a switching sequence according to the method of this invention;

Figure 4 shows a flow chart of a preferred embodiment of the method of this invention;

Figure 5 depicts a switching sequence determined by using the method of this invention for a 16x16 unary array;

Figure 6 depicts a sequential switching sequence for a 16x16 unary array;

Figure 7 depicts a symmetrical switching sequence for a 16x16 unary array;

Figure 8 depicts a switching sequence for a 16x16 unary array of the 12-bit thermometrically decoded D/A converter embedded in the commercial devices MTC-xx154, MTC-xx174 and MTC-xx454 of Alcatel Microelectronics;

Figure 9 depicts a switching sequence for a 16x16 unary array determined with a Q^2 random walk algorithm;

Figure 10 depicts an "INL bounded" switching sequence for a 16x16 unary array;

Figure 11 depicts a random switching sequence for a 16x16 unary array;

Figure 12 depicts an anti-symmetrical switching sequence in respect to the center of a 16x16 unary array;

Figure 13 depicts an improved anti-symmetrical switching sequence in respect to

the center of a 16x16 unary array;

Figures 14 and 15 compare the INL error functions of the switching sequences of Figures from 5 to 13 in function of the direction θ of the linear error distribution;

Tables 2 and 3 compare the maximum values of the absolute INL errors of many switching sequences obtained with known methods and the method of the invention for different values of the linear g_l and quadratic g_q coefficients;

Figure 16 depicts the switching sequence of an unary array of 1024 conducting branches of a 14-bit D/A converter of this invention, ten of which are thermometrically decoded.

DESCRIPTION OF AN EMBODIMENT OF THE INVENTION

Before illustrating the method of this invention, it is necessary to make some mathematical considerations.

As stated hereinbefore, the conducting branches of an array are affected by an error, which in electronic equipments may be due to thermal and/or mechanical phenomena, doping differences, and other process spread mechanisms of inaccuracy, distributed according to an error distribution function over the array.

In general, for a two-dimensional disposition of conducting branches, the relative error distribution $\varepsilon(x,y)$ may be approximated by a Taylor series expansion:

$$\varepsilon(x,y) = a_0 + a_{11}x + a_{12}y + a_{21}x^2 + a_{22}y^2 + a_{23}xy + \cdots$$

Truncating this series at the second order, neglecting the term $a_{23}xy$ and supposing that a_{21}=a_{22}, the linear $\varepsilon_l(x,y)$, quadratic $\varepsilon_q(x,y)$ and joint $\varepsilon_j(x,y)$ error distribution functions are, respectively,

$$\varepsilon_l(x,y) = g_l \cdot (\cos\theta \cdot x + \sin\theta \cdot y); \qquad \varepsilon_q(x,y) = g_q \cdot (x^2 + y^2) - a_0;$$

$$\varepsilon_j(x,y) = \varepsilon_l(x,y) + \varepsilon_q(x,y)$$

wherein θ is the angle of the linear error gradient, g_l is the slope, g_q is a quadratic

coefficient and a_0 is an offset value. This joint error distribution, represented in Figure 2, has proven to be a good approximation of real error distribution functions of unary arrays. The difference between the real error distribution and the joint error distribution is due to the components of higher order thereof and to a random error component.

In order to compensate errors due to the linear component of the error distribution, according to the method of the invention each pair of consecutive odd (2n-1) and even (2n) component of the switching sequence must be symmetrical in respect to the "center of gravity" of the two-dimensional array. In fact

$$\varepsilon_l(x,y) = -\varepsilon_l(-x,-y)$$

and thus, if pairs of consecutive branches $\{a,b\}$ and $\{g,h\}$ are disposed as depicted in Figure 3, the linear component of the error introduced by each pair is null.

Being $\overline{\varepsilon_q}$ the continuous component of the quadratic error distribution over the area of the array of branches, that is the mean value thereof, the quadratic error distribution is also given by

$$\varepsilon_q(x,y) = \overline{\varepsilon_q} + \varepsilon_q^{AC}(x,y)$$

wherein $\varepsilon_q^{AC}(x,y)$ is the alternate component of the quadratic error.

The offset term $\overline{\varepsilon_q}$ does not contribute to the INL error because it causes only an offset error in the slope of the transfer function of the D/A converter. On the contrary, the alternate component has positive and negative values that make the transfer function nonlinear, thus originating the INL error.

Therefore it is clear that, in order to have a switching sequence with a desired (small) INL error function, it is necessary to compensate the alternate component of the quadratic error distribution.

According to an essential embodiment of the method of the invention, the first step consists in defining an upper bound function and a lower bound function, symmetrical to each other, of the INL error function of the switching sequence to be generated. Then the error distribution function over the array is evaluated, in order to calculate the error associated to each pair of symmetrical branches. As stated before, each pair of successive branches must be symmetrical in respect to the center of gravity in order to compensate the component of the INL due to the linear error distribution.

These bound functions define the range of variation of the INL error and they may be constant, if the absolute INL error must be minimized.

The appropriate switching sequence is built by choosing a first pair of branches (1, 2) starting from any branch of the array and performing iteratively the following steps:

- calculating a corresponding value of the INL error function of the switching sequence being built,
- choosing as the successive pair, the pair of conducting branches that maximizes or minimizes the next value of the INL error function of the switching sequence though remaining comprised between the corresponding values of the upper bound and lower bound functions,
- if all other pairs do not meet the preceding conditions, then repeating the steps restarting from the first by choosing every time a different first pair of branches, and if the conditions cannot yet be met, changing at least one of the bound functions and restarting from the first step.

Finally, when the determination of the appropriate switching sequence has been completed, it is output.

Preferably, the above described method is repeated for all possible first pairs of conducting branches, thus generating a set of switching sequences affected by an INL error function comprised between the same bound functions. The optimal switching sequence is chosen from this set according to a pre-established

criterion.

Optionally, the bound functions may be closer to zero in correspondence of mid way values of the range of the converter compared to their value in correspondence of the two ends of the range of the converter.

A preferred embodiment of the method of this invention is described by the flow chart of Figure 4. In this case the symmetrical bound functions are constant and this constant value is half the maximum absolute value of the DNL error of the array.

An example of a 16x16 matrix describing a switching sequence determined according to the method of the invention illustrated in Figure 4 and for $g_l = g_q = 0.5$ is depicted in Figure 5. As may be noticed, the switching sequence has been determined by selecting every even conducting branch (2, 4, 6 ...) symmetrical to the preceding odd branch (1, 3, 5 ...) in respect to the center of the array.

Preferably, but not necessarily, the map of the switching sequence will be anti-symmetrical in respect to an axis of symmetry of the array, that means that the last branch of the sequence is symmetrical to the first branch in respect to that axis of symmetry, and so forth for the other branches. For example, the positions of the branches 256, 255, 254 etc. of the switching sequence of Figure 5 are symmetrical to the positions of the branches 1, 2, 3 etc. in respect to the horizontal axis of symmetry of the array.

For comparison purposes, eight other matrices obtained with different algorithms are depicted in Figures from 6 to 13.

The resulting absolute INL error values in function of the angle θ of the gradient of the linear error are compared in Figures 14 and 15 for $g_l = g_q = 0.5$. The values have been calculated after having normalized to 1 the maximum value of the linear or quadratic errors. As may be noticed, the absolute INL error of the switching sequence of Figure 5 is always smaller than that of the other sequences.

Moreover, differently from the switching sequences of Figures from 6 to 13 obtained by using the known methods, the absolute INL error of the switching sequence of Figure 5 is substantially independent from the angle θ. This is very important because it ensures that the method of the invention is not tied to a particular shape of the error distribution, as the method disclosed in the aforementioned paper by Y. Cong and R. L. Geiger.

Table 2 compares many switching sequence, indicating the maximum value of the absolute INL error for each of them. The references [1] and [2] indicate that the switching sequence is obtained using the method described in the mentioned paper by G. A. Van der Plas et al. and by Y. Cong and R. L. Geiger, respectively.

As may be noticed, the switching sequence of Figure 5 is the best one. This result is confirmed even using different values of g_l and g_q, as shown in Table 3. Even if these parameters undergo sensible variations, the maximum absolute INL error of the switching sequence obtained with the present method is substantially independent from them. This extraordinary result confirms that the method of this invention effectively compensates both the linear and the quadratic component of the error distribution.

The method of this invention may be applied whichever the shape of the array of conducting branches is, not only to two-dimensional square arrays.

A switching sequence generated according to the preferred embodiment of the method illustrated in Figure 4 for a substantially oval unary array of conducting branches of a 14-bit D/A converter of the invention, ten of which are thermometrically decoded, is depicted in Figure 16. As may be noticed, the switching sequence is anti-symmetrical in respect to the vertical axis of symmetry. The ten most significant bits of the input bit string of the D/A converter of the invention are thermometrically decoded, while the four least significant bits select as many conducting branches of a binary scaled array.

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CLAIMS

1. A method of generating a switching sequence for an unary array of conducting branches of a thermometrically decoded digital-to-analog converter, the conducting branches of which are affected by an error distributed over the array according to a certain error distribution function, comprising the steps of:

preliminary evaluating said error distribution function, fixing an upper bound function and a lower bound function symmetrical to each other of the INL error function associated to the switching sequence, determining the center of gravity of the array and calculating, by said preliminarily evaluated error distribution function, error values associated to each pair of conducting branches symmetrical in respect to the center of gravity of the array;

choosing pairs of successive conducting branches in the switching sequence such that every even conducting branch (2n) is substantially symmetrical to the preceding odd conducting branch (2n-1) in respect to said center of gravity;

building a switching sequence with an INL error function comprised between said upper bound and lower bound functions by:

a) starting from a first chosen pair of conducting branches (1, 2) of the switching sequence iteratively performing the following steps from b1) to b3) for all other pairs of conducting branches of the array:

b1) calculating a corresponding value of the INL error function of the switching sequence being built,

b2) choosing as the successive pair, the pair of conducting branches that maximizes or minimizes the next value of the INL error function of the switching sequence though remaining comprised between the corresponding values of said upper bound and lower bound functions,

b3) if all said other pairs do not meet the conditions of point b2), then repeating the steps from a) to b3) choosing every time a different first pair of branches, and if the conditions cannot yet be met, changing at

least one of said bound functions and restarting from point a);

c) when all other pairs of conducting branches of the unary array meet the conditions, outputting the resulting switching sequence.

2. The method of claim 1, further comprising the operations of:

repeating the steps from a) to c) for all possible first pairs of conducting branches using the same bound functions, obtaining a set of switching sequences whose INL error function is comprised between said bound functions;

choosing the switching sequence of said set that satisfies a pre-established criterion.

3. The method of claim 1, wherein said bound functions are constant.

4. The method of claim 3, wherein the value of said upper bound function is half the maximum value of the absolute value of the DNL error affecting the conducting branches of the array.

5. The method of claim 1, wherein said bound functions are closer to 0 in correspondence of mid way values of said switching sequence than in correspondence of the two ends of a range of conversion.

6. The method of claim 2, wherein said criterion consists in choosing the switching sequence of said set that is affected by the smallest absolute INL error.

7. The method of claim 2, wherein said criterion consists in choosing the switching sequence of said set that is affected by the smallest absolute DNL error in correspondence of mid way values of the switching sequence.

8. The method of claim 2, wherein said criterion consists in choosing the switching sequence of said set that is affected by the most evenly oscillating INL error function.

9. The method of claim 1, wherein said pairs of conducting branches are also chosen to make the switching sequence being built anti-symmetrical in

respect to an axis of symmetry of the unary array.

10. A thermometrically decoded digital/analog converter, comprising an unary array of conducting branches selectable by respective switches, characterized in that the switching sequence of said branches is generated by using the method of claim 1.

11. A computer program loadable in an internal memory of a computer, comprising a software code for performing the steps of the method of claim 1 when said program is executed on a computer.

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"METHOD OF GENERATING A SWITCHING SEQUENCE FOR AN UNARY ARRAY OF CONDUCTING BRANCHES AND A RELATIVE THERMOMETRICALLY DECODED DIGITAL-TO-ANALOG CONVERTER"

ABSTRACT

A method for determining switching sequences of two-dimensional unary arrays of conducting branches of thermometrically decoded D/A converters, in a way that will ensure that the relative INL error function be contained between pre-established symmetrical upper and lower bound functions, has been found. When these upper and lower bound functions are constant, the obtained switching sequence compensates both the linear and the quadratic component of the error distribution and therefore is affected by a very small absolute INL error, which depends essentially on the random component of the error distribution.

This method may be easily implemented by a computer program and allows the realization of thermometrically decoded D/A converters affected by a known limited INL error function.

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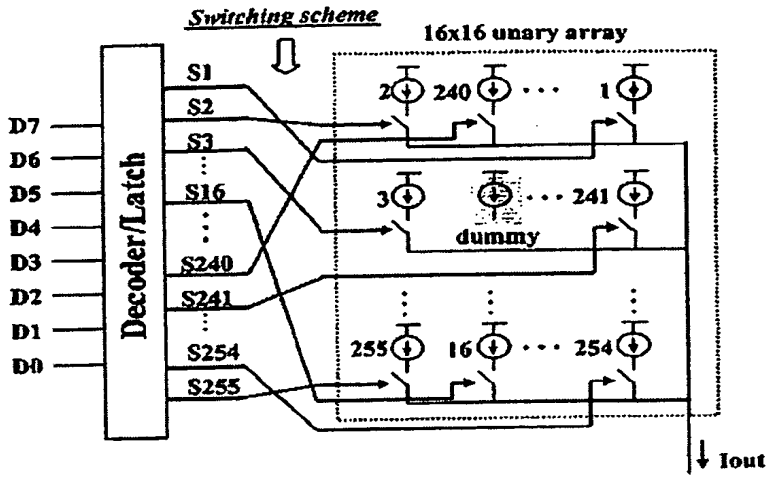

FIG. 1

Switch position	1	2	3	4	5	6	7	8
ε (%)	-7	-5	-3	-1	1	3	5	7
Sequential sw. seq.	1	2	3	4	5	6	7	8
ε (%)	-7	-5	-3	-1	1	3	5	7
INL (%)	-7	-12	-15	**-16**	-15	-12	-7	0
Symmetrical sw. seq.	7	5	3	1	2	4	6	8
ε (%)	-1	+1	-3	+3	-5	+5	-7	+7
INL (%)	+1	0	+3	0	+5	0	+7	0

TAB. 1

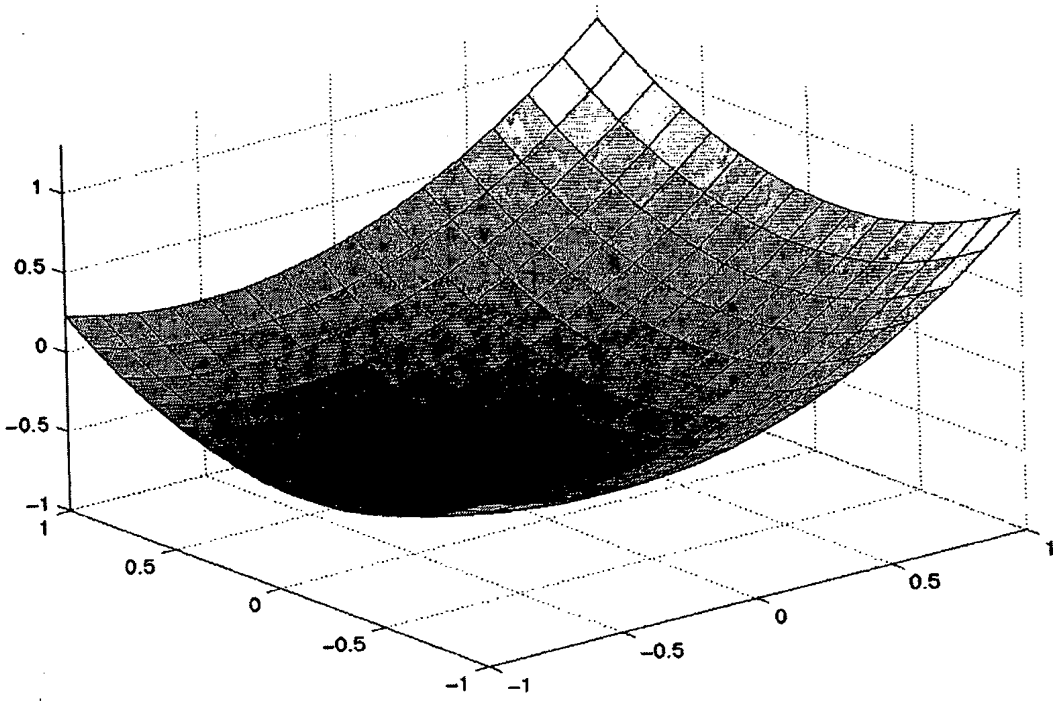

FIG. 2

a			
		g	
	h		
			b

FIG. 3

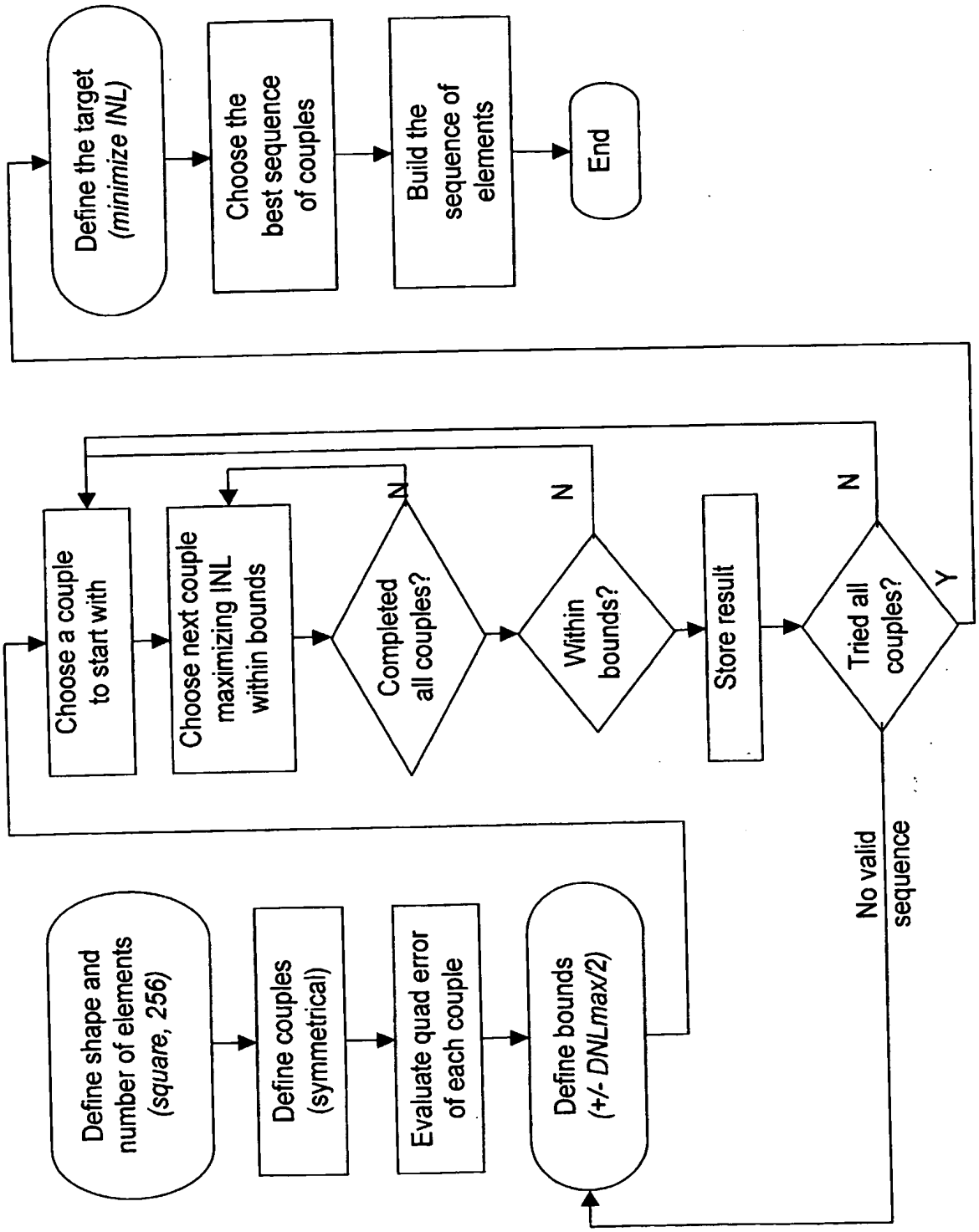
Define shape and number of elements (square, 256)
Define couples (symmetrical)
Evaluate quad error of each couple
Define bounds (+/- DNLmax/2)
Choose a couple to start with
Choose next couple maximizing INL within bounds
Completed all couples?
N
Within bounds?
N
Store result
Tried all couples?
N
Y
No valid sequence
Define the target (minimize INL)
Choose the best sequence of couples
Build the sequence of elements
End

FIG. 4

This work = 14-bit DAC

7	13	25	43	63	1	85	93	95	89	71	67	51	31	19	249
237	37	55	73	99	113	41	47	123	119	117	103	77	59	219	243
225	197	81	107	125	23	5	101	105	29	35	127	109	175	201	231
205	179	147	121	111	11	87	79	83	91	17	115	135	149	183	213
189	153	129	141	97	69	61	49	53	65	75	159	145	131	157	193
185	139	221	239	181	57	39	27	33	45	199	187	245	233	143	255
167	137	227	165	191	211	21	9	15	235	217	195	169	251	215	171
161	133	151	173	203	223	241	3	253	247	229	207	177	155	209	163
164	210	156	178	208	230	248	254	4	242	224	204	174	152	134	162
172	216	252	170	196	218	236	16	10	22	212	192	166	228	138	168
256	144	234	246	188	200	46	34	28	40	58	182	240	222	140	186
194	158	132	146	160	76	66	54	50	62	70	98	142	130	154	190
214	184	150	136	116	18	92	84	80	88	12	112	122	148	180	206
232	202	176	110	128	36	30	106	102	6	24	126	108	82	198	226
244	220	60	78	104	118	120	124	48	42	114	100	74	56	38	238
250	20	32	52	68	72	90	96	94	86	2	64	44	26	14	8

FIG. 5

Row - Column															
1	2	3	4	5	6	7	8	9	10	11	12	13	14	15	16
17	18	19	20	21	22	23	24	25	26	27	28	29	30	31	32
33	34	35	36	37	38	39	40	41	42	43	44	45	46	47	48
49	50	51	52	53	54	55	56	57	58	59	60	61	62	63	64
65	66	67	68	69	70	71	72	73	74	75	76	77	78	79	80
81	82	83	84	85	86	87	88	89	90	91	92	93	94	95	96
97	98	99	100	101	102	103	104	105	106	107	108	109	110	111	112
113	114	115	116	117	118	119	120	121	122	123	124	125	126	127	128
129	130	131	132	133	134	135	136	137	138	139	140	141	142	143	144
145	146	147	148	149	150	151	152	153	154	155	156	157	158	159	160
161	162	163	164	165	166	167	168	169	170	171	172	173	174	175	176
177	178	179	180	181	182	183	184	185	186	187	188	189	190	191	192
193	194	195	196	197	198	199	200	201	202	203	204	205	206	207	208
209	210	211	212	213	214	215	216	217	218	219	220	221	222	223	224
225	226	227	228	229	230	231	232	233	234	235	236	237	238	239	240
241	242	243	244	245	246	247	248	249	250	251	252	253	254	255	256

FIG. 6

Seq Row-Column Symm

255	253	251	249	247	245	243	241	239	237	235	233	231	229	227	225
223	221	219	217	215	213	211	209	207	205	203	201	199	197	195	193
191	189	187	185	183	181	179	177	175	173	171	169	167	165	163	161
159	157	155	153	151	149	147	145	143	141	139	137	135	133	131	129
127	125	123	121	119	117	115	113	111	109	107	105	103	101	99	97
95	93	91	89	87	85	83	81	79	77	75	73	71	69	67	65
63	61	59	57	55	53	51	49	47	45	43	41	39	37	35	33
31	29	27	25	23	21	19	17	15	13	11	9	7	5	3	1
2	4	6	8	10	12	14	16	18	20	22	24	26	28	30	32
34	36	38	40	42	44	46	48	50	52	54	56	58	60	62	64
66	68	70	72	74	76	78	80	82	84	86	88	90	92	94	96
98	100	102	104	106	108	110	112	114	116	118	120	122	124	126	128
130	132	134	136	138	140	142	144	146	148	150	152	154	156	158	160
162	164	166	168	170	172	174	176	178	180	182	184	186	188	190	192
194	196	198	200	202	204	206	208	210	212	214	216	218	220	222	224
226	228	230	232	234	236	238	240	242	244	246	248	250	252	254	256

FIG. 7

12-bit DAC

222	158	94	30	62	126	190	254	250	186	122	58	26	90	154	218
214	150	86	22	54	118	182	246	242	178	114	50	18	82	146	210
206	142	78	14	46	110	174	238	234	170	106	42	10	74	138	202
198	134	70	6	38	102	166	230	226	162	98	34	2	66	130	194
229	165	101	37	5	69	133	197	193	129	65	1	33	97	161	225
237	173	109	45	13	77	141	205	201	137	73	9	41	105	169	233
245	181	117	53	21	85	149	213	209	145	81	17	49	113	177	241
253	189	125	61	29	93	157	221	217	153	89	25	57	121	185	249
251	187	123	59	27	91	155	219	223	159	95	31	63	127	191	255
243	179	115	51	19	83	147	211	215	151	87	23	55	119	183	247
235	171	107	43	11	75	139	203	207	143	79	15	47	111	175	239
227	163	99	35	3	67	131	195	199	135	71	7	39	103	167	231
196	132	68	4	36	100	164	228	232	168	104	40	8	72	136	200
204	140	76	12	44	108	172	236	240	176	112	48	16	80	144	208
212	148	84	20	52	116	180	244	248	184	120	56	24	88	152	216
220	156	92	28	60	124	188	252	256	192	128	64	32	96	160	224

FIG. 8

Q2 Random Walk

39	71	151	215	43	75	155	219	36	68	148	212	47	79	159	223
103	231	23	183	107	235	27	187	100	228	20	180	111	239	31	191
167	7	247	119	171	11	251	123	164	4	244	116	175	15	255	127
199	135	87	55	203	139	91	59	196	132	84	52	207	143	95	63
35	67	147	211	41	73	153	217	45	77	157	221	34	66	146	210
99	227	19	179	105	233	25	185	109	237	29	189	98	226	18	178
163	3	243	115	169	9	249	121	173	13	253	125	162	2	242	114
195	131	83	51	201	137	89	57	205	141	93	61	194	130	82	50
48	80	160	224	33	65	145	209	40	72	152	216	38	70	150	214
112	240	32	192	97	225	17	177	104	232	24	184	102	230	22	182
176	16	256	128	161	1	241	113	168	8	248	120	166	6	246	118
208	144	96	64	193	129	81	49	200	136	88	56	198	134	86	54
37	69	149	213	46	78	158	222	44	76	156	220	42	74	154	218
101	229	21	181	110	238	30	190	108	236	28	188	106	234	26	186
165	5	245	117	174	14	254	126	172	12	252	124	170	10	250	122
197	133	85	53	206	142	94	62	204	140	92	60	202	138	90	58

FIG. 9

INL-bounded

206	174	30	62	195	163	19	51	199	167	23	55	196	164	20	52
238	142	126	94	227	131	115	83	231	135	119	87	228	132	116	84
110	14	254	222	99	3	243	211	103	7	247	215	100	4	244	212
78	46	158	190	67	35	147	179	71	39	151	183	68	36	148	180
193	161	17	49	208	176	32	64	205	173	29	61	204	172	28	60
225	129	113	81	240	144	128	96	237	141	125	93	236	140	124	92
97	1	241	209	112	16	256	224	109	13	253	221	108	12	252	220
65	33	145	177	80	48	160	192	77	45	157	189	76	44	156	188
201	169	25	57	197	165	21	53	202	170	26	58	200	168	24	56
233	137	121	89	229	133	117	85	234	138	122	90	232	136	120	88
105	9	249	217	101	5	245	213	106	10	250	218	104	8	248	216
73	41	153	185	69	37	149	181	74	42	154	186	72	40	152	184
203	171	27	59	198	166	22	54	194	162	18	50	207	175	31	63
235	139	123	91	230	134	118	86	226	130	114	82	239	143	127	95
107	11	251	219	102	6	246	214	98	2	242	210	111	15	255	223
75	43	155	187	70	38	150	182	66	34	146	178	79	47	159	191

FIG. 10

best of 1000 random

61	69	120	17	133	83	200	88	245	86	241	223	141	76	228	99
137	24	80	15	226	46	181	93	144	108	161	102	16	29	256	100
250	197	158	98	138	85	215	164	186	89	238	187	193	4	110	94
52	131	221	190	227	175	183	167	43	163	10	11	235	165	156	113
213	147	101	92	210	18	254	95	111	3	224	134	145	75	116	231
72	206	135	31	162	36	149	62	35	7	107	189	251	168	105	178
219	19	8	63	194	27	170	146	41	124	125	152	53	54	237	56
55	28	229	44	179	171	177	73	249	176	1	208	22	174	234	60
244	39	204	247	202	184	236	121	122	23	42	217	79	67	5	38
58	212	21	64	157	129	203	150	26	139	14	142	166	230	48	195
191	126	132	97	140	106	104	45	248	196	34	218	240	153	68	59
220	47	51	205	185	13	9	71	117	128	211	66	30	12	199	155
118	169	246	173	225	207	136	180	81	232	222	82	253	78	77	160
123	209	57	96	114	91	242	214	70	233	84	216	40	192	65	252
130	182	143	154	6	119	198	74	159	201	20	2	49	127	188	50
151	103	25	172	239	90	33	148	243	255	87	32	115	37	112	109

FIG. 11

Magic

256	2	3	253	252	6	7	249	248	10	11	245	244	14	15	241
17	239	238	20	21	235	234	24	25	231	230	28	29	227	226	32
33	223	222	36	37	219	218	40	41	215	214	44	45	211	210	48
208	50	51	205	204	54	55	201	200	58	59	197	196	62	63	193
192	66	67	189	188	70	71	185	184	74	75	181	180	78	79	177
81	175	174	84	85	171	170	88	89	167	166	92	93	163	162	96
97	159	158	100	101	155	154	104	105	151	150	108	109	147	146	112
144	114	115	141	140	118	119	137	136	122	123	133	132	126	127	129
128	130	131	125	124	134	135	121	120	138	139	117	116	142	143	113
145	111	110	148	149	107	106	152	153	103	102	156	157	99	98	160
161	95	94	164	165	91	90	168	169	87	86	172	173	83	82	176
80	178	179	77	76	182	183	73	72	186	187	69	68	190	191	65
64	194	195	61	60	198	199	57	56	202	203	53	52	206	207	49
209	47	46	212	213	43	42	216	217	39	38	220	221	35	34	224
225	31	30	228	229	27	26	232	233	23	22	236	237	19	18	240
16	242	243	13	12	246	247	9	8	250	251	5	4	254	255	1

FIG. 12

Modified Magic

253	9	237	25	33	213	49	197	254	10	238	26	34	214	50	198
65	181	81	165	157	105	141	121	66	182	82	166	158	106	142	122
125	137	109	153	161	85	177	69	126	138	110	154	162	86	178	70
193	53	209	37	29	233	13	249	194	54	210	38	30	234	14	250
5	241	21	225	217	45	201	61	6	242	22	226	218	46	202	62
185	77	169	93	101	145	117	129	186	78	170	94	102	146	118	130
133	113	149	97	89	173	73	189	134	114	150	98	90	174	74	190
57	205	41	221	229	17	245	1	58	206	42	222	230	18	246	2
255	11	239	27	35	215	51	199	256	12	240	28	36	216	52	200
67	183	83	167	159	107	143	123	68	184	84	168	160	108	144	124
127	139	111	155	163	87	179	71	128	140	112	156	164	88	180	72
195	55	211	39	31	235	15	251	196	56	212	40	32	236	16	252
7	243	23	227	219	47	203	63	8	244	24	228	220	48	204	64
187	79	171	95	103	147	119	131	188	80	172	96	104	148	120	132
135	115	151	99	91	175	75	191	136	116	152	100	92	176	76	192
59	207	43	223	231	19	247	3	60	208	44	224	232	20	248	4

FIG. 13

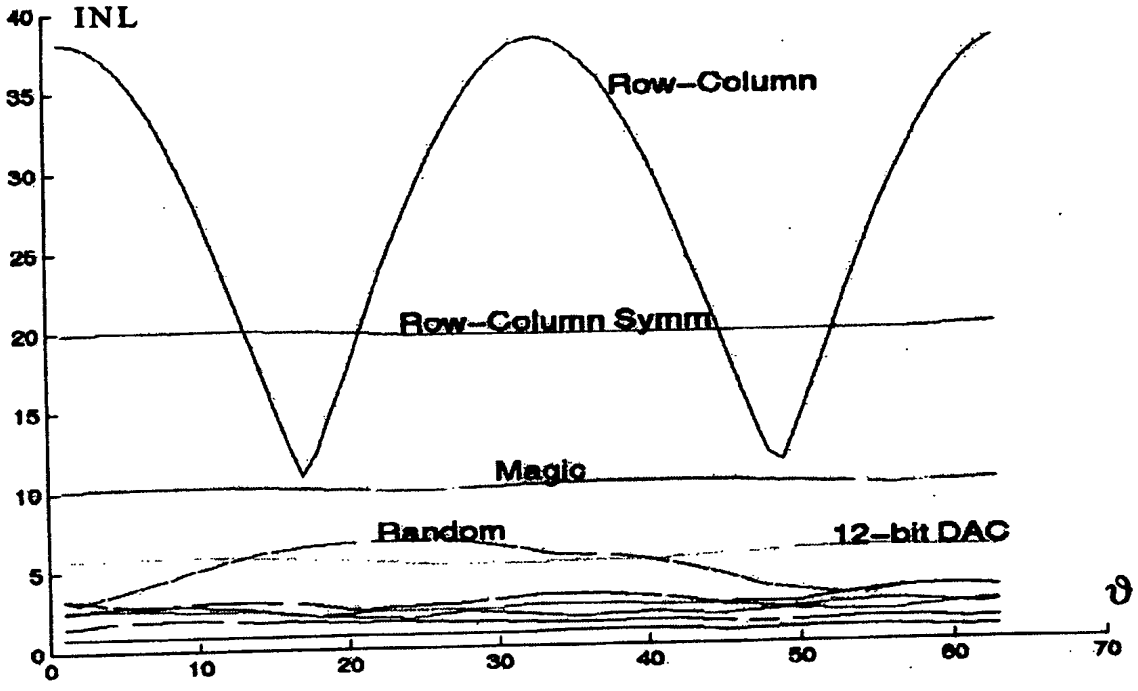
INL
Row–Column
Row–Column Symm
Magic
Random
12–bit DAC
ϑ
40
35
30
25
20
15
10
5
0
0
10
20
30
40
50
60
70

FIG. 14

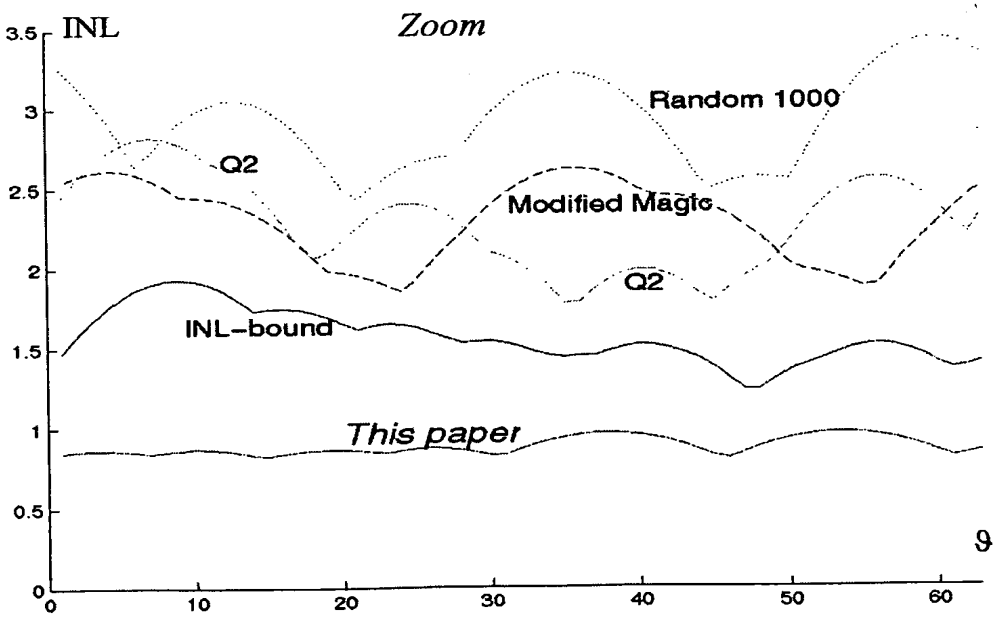
INL
Zoom
Random 1000
Q2
Modified Magic
Q2
INL–bound
This paper
ϑ
3.5
3
2.5
2
1.5
1
0.5
0
0
10
20
30
40
50
60

FIG. 15

	16 x 16 matrix comparison result (g_I= g_Q=0.5)	
	Algorithm/Sequence	Maximum absolute INL
Row-Col	Row-Column basic	38.1
	Row-Column symm. Seq.	20
	Row-Column hier symm seq. [2]	10.2
Hierarchic.	12-bit C05 DAC	5.9
	Q2 random walk [1]	2.8
	Hier. switch, INL-bounded [2]	1.93
Improvements	Random (1 trial)	6.8
	Random (best of 1k trials)	3.4
	Magic	10.2
	Modified Magic	2.6
	This work	*0.96*

TAB. 2

Maximum absolute INL error			
g_I =	0.3	0.5	0.7
g_Q =	0.7	0.5	0.3
Q^2 rand walk	2.26	2.8	3.38
INL-bounded	1.56	1.93	2.4
This work	*0.95*	*0.96*	*1.04*

TAB. 3

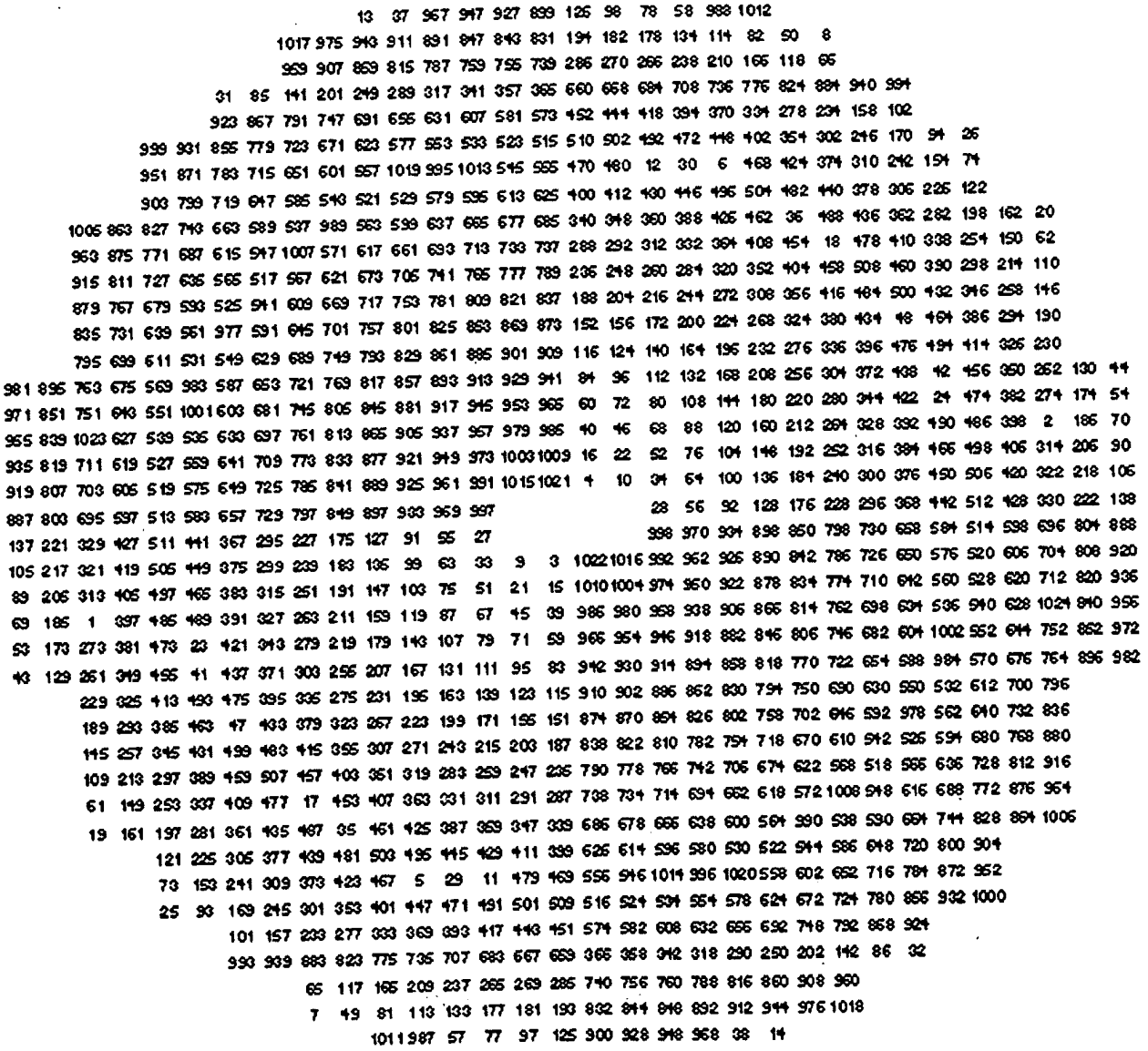
13 37 967 947 927 899 125 98 78 58 988 1012
1017 975 943 911 891 947 843 831 194 182 178 134 114 82 50 8
959 907 859 815 787 759 755 739 286 270 266 238 210 165 118 65
31 85 141 201 249 289 317 341 357 365 660 658 684 708 736 776 824 884 940 994
923 867 791 747 691 655 631 607 581 573 452 444 418 394 370 334 278 234 158 102
939 931 855 779 723 671 623 577 553 533 523 515 510 502 492 472 448 402 354 302 246 170 94 26
951 871 783 715 651 601 557 1019 995 1013 545 555 470 460 12 30 6 468 424 374 310 242 154 74
903 799 719 647 585 543 521 529 579 595 613 625 400 412 430 446 496 504 482 440 378 306 225 122
1005 863 827 743 663 589 537 989 563 599 637 665 677 685 340 348 360 388 405 462 36 488 436 362 282 198 162 20
963 875 771 687 615 547 1007 571 617 661 693 713 733 737 288 292 312 332 364 408 454 18 478 410 338 254 150 62
915 811 727 635 565 517 567 621 673 705 741 765 777 789 236 248 260 284 320 352 404 458 508 460 390 298 214 110
879 767 679 593 525 541 609 669 717 753 781 809 821 837 188 204 216 244 272 308 356 416 484 500 432 346 258 146
835 731 639 561 577 591 645 701 757 801 825 853 869 873 152 156 172 200 224 268 324 380 434 48 464 386 294 190
795 699 611 531 549 629 689 749 793 829 861 895 901 909 116 124 140 164 196 232 276 336 396 476 494 414 326 230
981 895 763 675 569 583 587 653 721 769 817 857 893 913 929 941 84 96 112 132 168 208 256 304 372 438 42 456 350 262 130 44
971 851 751 643 551 1001 603 681 745 805 845 881 917 945 953 965 60 72 80 108 144 180 220 280 344 422 24 474 382 274 174 54
955 839 1023 627 539 535 633 697 761 813 865 905 937 957 979 985 40 46 68 88 120 160 212 284 328 392 490 486 398 2 186 70
935 819 711 619 527 559 641 709 773 833 877 921 949 973 1003 1009 16 22 52 76 104 146 192 252 316 384 466 498 406 314 206 90
919 807 703 605 519 575 649 725 785 841 889 925 961 991 1015 1021 4 10 34 64 100 136 184 240 300 376 450 506 420 322 218 106
887 800 695 597 513 583 657 729 797 849 897 933 969 997 28 56 92 128 176 228 296 368 442 512 428 330 222 138
137 221 329 427 511 441 367 295 227 175 127 91 55 27 398 970 934 898 850 798 730 658 594 514 598 696 804 888
105 217 321 419 505 449 375 299 239 183 135 99 63 33 9 3 1022 1016 992 962 926 890 842 786 726 650 576 520 606 704 808 920
89 205 313 405 497 465 383 315 251 191 147 103 75 51 21 15 1010 1004 974 950 922 878 834 774 710 642 560 528 620 712 820 936
69 185 1 397 485 469 391 327 263 211 159 119 87 67 45 39 986 980 958 938 906 865 814 762 698 634 536 540 628 1024 940 956
53 173 273 381 473 23 421 343 279 219 179 143 107 79 71 59 966 954 946 918 882 846 806 746 682 604 1002 552 644 752 852 972
43 129 261 349 495 41 437 371 303 255 207 167 131 111 95 83 942 930 914 894 858 818 770 722 654 588 984 570 676 764 896 982
229 325 413 493 475 395 335 275 231 195 163 139 123 115 910 902 886 862 830 794 750 690 630 550 532 612 700 796
189 293 385 463 47 433 379 323 267 223 199 171 155 151 874 870 854 826 802 758 702 646 592 578 562 640 732 836
115 257 345 431 499 483 415 355 307 271 243 215 203 187 838 822 810 782 754 718 670 610 542 526 594 680 768 880
109 213 297 389 459 507 457 403 361 319 283 259 247 235 790 778 766 742 706 674 622 568 518 566 636 728 812 916
61 149 253 337 409 477 17 453 407 363 331 311 291 287 738 734 714 694 662 618 572 1008 948 616 688 772 876 964
19 161 197 281 361 435 487 35 461 425 387 359 347 339 686 678 666 638 600 564 990 538 590 664 744 828 894 1006
121 225 305 377 439 481 503 495 445 429 411 399 626 614 596 580 530 522 544 586 648 720 800 904
73 153 241 309 373 423 467 5 29 11 479 469 556 546 1014 996 1020 558 602 652 716 784 872 952
25 93 169 245 301 353 401 447 471 491 501 509 516 524 534 554 578 624 672 724 780 856 932 1000
101 157 233 277 333 369 393 417 443 451 574 582 608 632 656 692 748 792 868 924
990 939 883 823 775 735 707 683 667 659 366 358 342 318 290 250 202 142 86 32
65 117 165 209 237 265 269 286 740 756 760 788 816 860 908 960
7 49 81 113 133 177 181 193 832 844 848 892 912 944 976 1018
1011 987 57 77 97 125 900 928 948 968 38 14

FIG. 16

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